### **EMC TEST REPORT**

For

## Shanghai Maitu Chemical Technology Ltd

Ink-jet printer

Test Model: WM1660SPE

Additional Model No.: PU block

Prepared for : Shanghai Maitu Chemical Technology Ltd

Address : 201500, China, Shanghai, Jinshan District, Shisan Road,

No. 8, 6th Floor, Room 619, C

Prepared by : Shenzhen AOCE Electronic Technology Service Co., Ltd

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Date of receipt of test: August 29, 2025

sample

Number of tested samples : 1

Serial number : Prototype

Date of Test : August 29, 2025~September 9, 2025

Date of Report : September 9, 2025

EMC TEST REPORT EN IEC 61000-6-4:2019 & EN IEC 61000-6-2:2019

Report Reference No. .....:: AOC250909101E

Date Of Issue.....:: September 9, 2025

Testing Laboratory Name ....: Shenzhen AOCE Electronic Technology Service Co., Ltd

Address .....: Room 202, 2nd Floor, No.12th Building of Xinhe Tongfuyu Industrial Park, Fuhai Street, Baoan District, Shenzhen,

Guangdong, China

Testing Location/ Procedure...: Full application of Harmonised standards■

Partial application of Harmonised standards

Other standard testing method

Applicant's Name.....: Shanghai Maitu Chemical Technology Ltd

Address ......: 201500, China, Shanghai, Jinshan District, Shisan Road,

No. 8, 6th Floor, Room 619, C

**Test Specification** 

Standard .....: EN IEC 61000-6-2:2019

EN IEC 61000-6-4:2019

EN IEC 61000-3-2:2019+A1:2021+A2:2024

EN 61000-3-3:2013+A1:2019+A2:2021+AC:2022

Test Report Form No. .....: : AOCEMC-1.0

TRF Originator.....: Shenzhen AOCE Electronic Technology Service Co., Ltd

Master TRF.....: Dated 2017-09

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Test Item Description. .....: : Ink-jet printer

Trade Mark .....: N/A

Test Model.....: WM1660SPE

Ratings ......: 220V, 50Hz, 100W

Result .....: Positive

Compiled by: Supervised by: Approved by:

Bill Hu Joey Lin My Je

Bill Hu/ Administrators Joey Liu/ Technique principal Murry Yu/ Manager

## **EMC -- TEST REPORT**

Test Report AOC250909101E

September 9, 2025
Date of issue

Test Model.....: : WM1660SPE EUT.....:: Ink-jet printer Applicant.....: : Shanghai Maitu Chemical Technology Ltd Address......: 201500, China, Shanghai, Jinshan District, Shisan Road, No. 8, 6th Floor, Room 619, C Telephone.....: : / Manufacturer.....: : Shanghai Maitu Chemical Technology Ltd Address......: : 201500, China, Shanghai, Jinshan District, Shisan Road, No. 8, 6th Floor, Room 619, C Telephone.....:: : / Fax.....: : / Factory.....: : Shanghai Maitu Chemical Technology Ltd Address......: 201500, China, Shanghai, Jinshan District, Shisan Road, No. 8, 6th Floor, Room 619, C Telephone.....: : / Fax.....:: : /

Test Result Positive
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The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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#### 1. GENERAL INFORMATION

## 1.1. Product Description for Equipment Under Test (EUT)

EUT : Ink-jet printer
Test Model : WM1660SPE

Model No. List: WM1660SPE, PU block

Model No. difference: The internal structure of the product is the same, only the size

and color are different.

Power Supply: 220V, 50Hz, 100W

Hardware Version : /

Software Version : /

## 1.3. Related Submittal(s)/Grant(s)

No Related Submittals.

## 1.4. Test Methodology

All measurements contained in this report were conducted with EN IEC 61000-6-2:2019, EN IEC 61000-6-4:2019, EN IEC 61000-3-2:2019+A1:2021+A2:2024 and EN 61000-3-3:2013+A1:2019+A2:2021+AC:2022.

### 1.6. Support Equipment List

Manufacturer	Description	Model	Serial Number	Certificate
			-	

#### 1.7. External I/O

I/O Port Description Quantity		Cable
/	/	/

## 1.8. List Of Measuring Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1	X-series USB Peak and Average Power Sensor Aglient	Agilent	U2021XA	MY54080022	2025-04-24	2026-04-23
2	4 CH. Simultaneous Sampling 14 Bits 2MS/s	Agilent	U2531A	MY54080016	2025-04-24	2026-04-23
3	Test Software	Ascentest	AT890-SW	20160630	N/A	N/A
4	RF Control Unit	Ascentest	AT890-RFB	N/A	2025-04-24	2026-04-23
5	ESA-E SERIES SPECTRUM ANALYZER	Agilent	E4407B	MY41440754	2025-04-24	2026-04-23
6	MXA Signal Analyzer	Agilent	N9020A	MY49100040	2025-04-24	2026-04-23
7	SPECTRUM ANALYZER	R&S	FSP	100503	2025-04-24	2026-04-23
8	MXG Vector Signal Generator	Agilent	N5182A	MY47071151	2025-04-24	2026-04-23
9	ESG VECTOR SIGNAL GENERATOR	Agilent	E4438C	MY42081396	2025-04-24	2026-04-23
10	PSG Analog Signal Generator	Agilent	E8257D	MY4520521	2025-04-24	2026-04-23
11	Universal Radio Communication Tester	R&S	CMU 200	105788	2025-04-24	2026-04-23
12	WIDEBAND RADIO COMMUNICATION TESTER	R&S	CMW 500	103818	2025-04-24	2026-04-23
13	RF Control Unit	Tonscend	JS0806-1	N/A	2025-04-24	2026-04-23
14	DC Power Supply	Agilent	E3642A	N/A	2025-04-24	2026-04-23
15	LTE Test Software	Tonscend	JS1120-1	N/A	N/A	N/A
16	Temperature & Humidity Chamber	GUANGZHOU GOGNWEN	GDS-100	70932	2025-04-24	2026-04-23
17	DC Source	CHROMA	62012P-80-60	34782951	2025-04-24	2026-04-23
18	RF Filter	Micro-Tronics	BRC50718	S/N-017	2025-04-24	2026-04-23
19	RF Filter	Micro-Tronics	BRC50719	S/N-011	2025-04-24	2026-04-23
20	RF Filter	Micro-Tronics	BRC50720	S/N-011	2025-04-24	2026-04-23
21	RF Filter	Micro-Tronics	BRC50721	S/N-013	2025-04-24	2026-04-23
22	RF Filter	Micro-Tronics	BRM50702	S/N-195	2025-04-24	2026-04-23
23	Splitter/Combiner	Micro-Tronics	PS2-15	CB11-20	2025-04-24	2026-04-23
24	Splitter/Combiner	Micro-Tronics	CB11-20	N/A	2025-04-24	2026-04-23
25	Attenuator	Micro-Tronics	PAS-8-10	S/N23466	2025-04-24	2026-04-23
26	Exposure Level Tester	Narda	ELT-400	N-0713	2025-04-24	2026-04-23
27	B-Field Probe	Narda	ELT-400	M-1154	2025-04-24	2026-04-23
28	3m Semi Anechoic Chamber	SIDT FRANKONIA	SAC-3M	03CH03-HY	2025-04-24	2026-04-23
29	Positioning Controller	MF	MF-7082	/	2025-04-24	2026-04-23
30	EMI Test Software	AUDIX	E3	N/A	2025-04-24	2026-04-23
31	EMI Test Receiver	R&S	ESR 7	101181	2025-04-24	2026-04-23
32	AMPLIFIER	QuieTek	QTK-A2525G	CHM10809065	2025-04-24	2026-04-23
33	Active Loop Antenna	SCHWARZBECK	FMZB 1519B	00005	2025-04-24	2026-04-23
34	By-log Antenna	SCHWARZBECK	VULB9163	9163-470	2025-04-24	2026-04-23
35	Horn Antenna	SCHWARZBECK	BBHA 9120 D	9120D-1925	2025-04-24	2026-04-23
36	Broadband Horn Antenna	SCHWARZBECK	BBHA 9170	791	2025-04-24	2026-04-23
37	Broadband Preamplifier	SCHWARZBECK	BBV 9719	9719-025	2025-04-24	2026-04-23
38	RF Cable-R03m	Jye Bao	RG142	CB021	2025-04-24	2026-04-23
39	RF Cable-HIGH	SUHNER	SUCOFLEX 106	03CH03-HY	2025-04-24	2026-04-23

Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
40	Artificial Mains	R&S	ENV216	101288	2025-04-24	2026-04-23
41	Power Analyzer Test System	Voltech	PM6000	20000670053	2025-04-24	2026-04-23
42	ESD Simulator	SCHLODER	SESD 230	604035	2025-04-24	2026-04-23
43	RF POWER AMPLIFIER	OPHIR	5225R	1052	2025-04-24	2026-04-23
44	RF POWER AMPLIFIER	OPHIR	5273F	1019	2025-04-24	2026-04-23
45	Stacked Broadband Log Periodic	SCHWARZBECK	STLP 9128	9128ES-145	2025-04-24	2026-04-23
46	Stacked Mikrowellen LogPer Antenna	SCHWARZBECK	STLP 9149	9149-482	2025-04-24	2026-04-23
47	Electric field probe	Narda S TS /PMM	EP601	611WX80208	2025-04-24	2026-04-23
48	Power Meter	Agilent	E4419B	MY45104493	2025-04-24	2026-04-23
49	Power Sensor	Agilent	E9301H	MY41495234	2025-04-24	2026-04-23
50	Power Sensor	Agilent	E4412A	MY41500229	2025-04-24	2026-04-23
51	Sound Level meter	BK Precision	735	73500873100	2025-04-24	2026-04-23
52	Audio Analyzer	R&S	UPV	1146.2003K0	2025-04-24	2026-04-23
53	Mouse Simulation	Bruel & Kjaer	4227	A0304216	2025-04-24	2026-04-23
54	Ear Simulation and supply	Bruel & Kjaer	2669.4182.5935	A0305284	2025-04-24	2026-04-23
55	Acoustical Calibrators	Bruel & Kjaer	4231	A0304215	2025-04-24	2026-04-23
56	Immunity Simulative Generator	EM TEST	UCS500-M4	0101-34	2025-04-24	2026-04-23
57	Simulator	FRANKONIA	CIT-10	A126A1195	2025-04-24	2026-04-23
58	CDN	FRANKONIA	CDN-M2	5100100100	2025-04-24	2026-04-23
59	CDN	FRANKONIA	CDN-M3	0900-11	2025-04-24	2026-04-23
60	Attenuator	FRANKONIA	ATT6	0010222A	2025-04-24	2026-04-23
61	Infuse tongs	EM TEST	EM-Clamp	0513A031201	2025-04-24	2026-04-23
62	Voltage dips and up generator	3CTEST	VDG-1105G	EC0171014	2025-04-24	2026-04-23

## 1.9. Measurement Uncertainty

Item	MU	Remark
Uncertainty for Power point Conducted Emissions Test	2.42dB	
Uncertainty for Radiation Emission test in 3m chamber	3.54dB	Polarize: V
(30MHz to 1GHz)	4.1dB	Polarize: H
Uncertainty for Radiation Emission test in 3m chamber	2.08dB	Polarize: H
(1GHz to 25GHz)	2.56dB	Polarize: V
Uncertainty for radio frequency	0.01ppm	
Uncertainty for conducted RF Power	0.65dB	
Uncertainty for temperature	0.2°C	
Uncertainty for humidity	1%	
Uncertainty for DC and low frequency voltages	0.06%	

## 1.10. Description Of Test Modes

There was 3 test Modes. TM1 to TM3 were shown below:

**TM1**: Operate in normal work mode;

**TM2**: Power on mode;

TM3: Idle mode

1. All test modes were tested, but we only recorded the worst case in this report.

<sup>\*\*\*</sup>Note:

## 2. SUMMARY OF TEST RESULTS

Rule	Description of Test Items	Result
§11	EN 61000-6-4 Conducted Emission (AC mains input/output port)	Compliant
§11	EN 61000-6-4 Conducted Emission (DC power input/output port)	N/A*
§11	EN 61000-6-4 Conducted Emission (Wired network port)	N/A*
§11	EN 61000-6-4 Radiated Emission (Enclosure of ancillary equipment)	Compliant
§	Harmonic current emissions (AC mains input port)	Compliant
§	Voltage fluctuations and flicker (AC mains input port)	Compliant
§8	EN 61000-6-2 Electrostatic discharge (Enclosure port) (EN 61000-4-2)	Compliant
§8	EN 61000-6-2 RF electromagnetic field (80MHz to 1000MHz) (Enclosure port) (EN 61000-4-3)	Compliant
§8	EN 61000-6-2 Fast transients common mode (signal, wired network and control ports, DC and AC power ports) (EN 61000-4-4)	Compliant
<b>§</b> 8	EN 61000-6-2 Surges, line to line and line to ground (AC mains power input ports, wired network ports) (EN 61000-4-5)	Compliant
§8	EN 61000-6-2 RF common mode 0.15MHz to 80MHz (signal, wired network and control ports, DC and AC power ports) (EN 61000-4-6)	Compliant
§8	EN 61000-6-2 Voltage dips and interruptions (AC mains power input ports) (EN 61000-4-11)	Compliant

#### 3. LINE CONDUCTED EMISSION

#### 3.1. Conducted Emission Limit

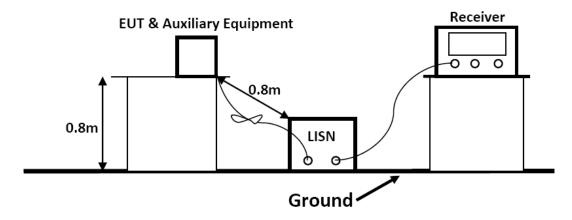
Relevant Standard(s): EN IEC 61000-6-2:2019 /CISPR 11:2009

Limits for Line Conducted Emission				
Frequency Limit (dBμV)				
(MHz)	Quasi-peak Level Average Level			
0.15 ~ 0.50	79 *	66 *		
0.50 ~ 30.00	73.0	60		

NOTE1-The lower limit shall apply at the transition frequencies.

NOTE2-The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

## 3.2. Test Configuration



The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle.

The spacing between the peripherals was 10 cm.

The EUT received charging power from the Adapter which received power through a LISN supplying power of AC 380V/50Hz.

## 3.3. EMI Test Receiver Setup

During the conducted emission test, the EMI test receiver was set with the following configurations:

Receiver Parameter	Setting
Attenuation	Auto
Start ~ Stop Frequency	150KHz ~ 30MHz
(IF)RBW	9kHz

All data was recorded in the Quasi-peak and average detection mode.

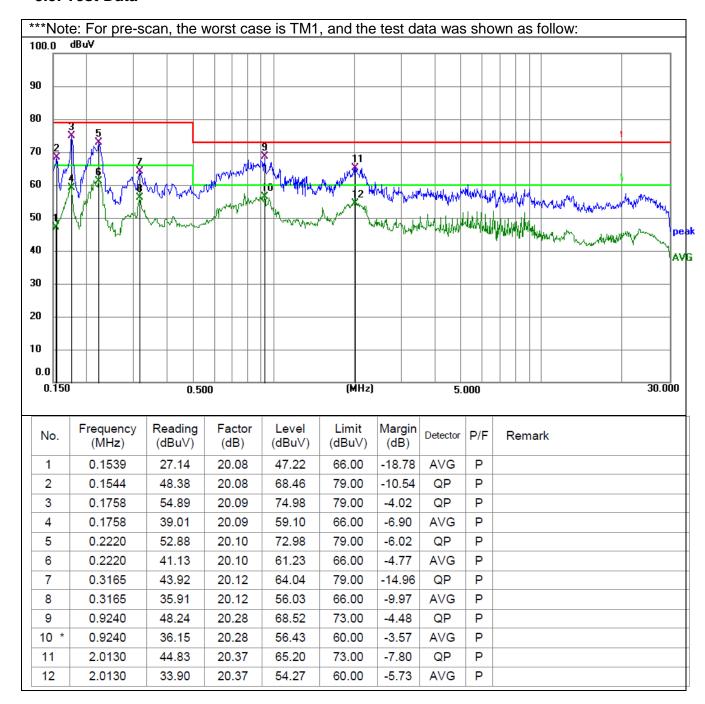
#### 3.4. Test Procedure

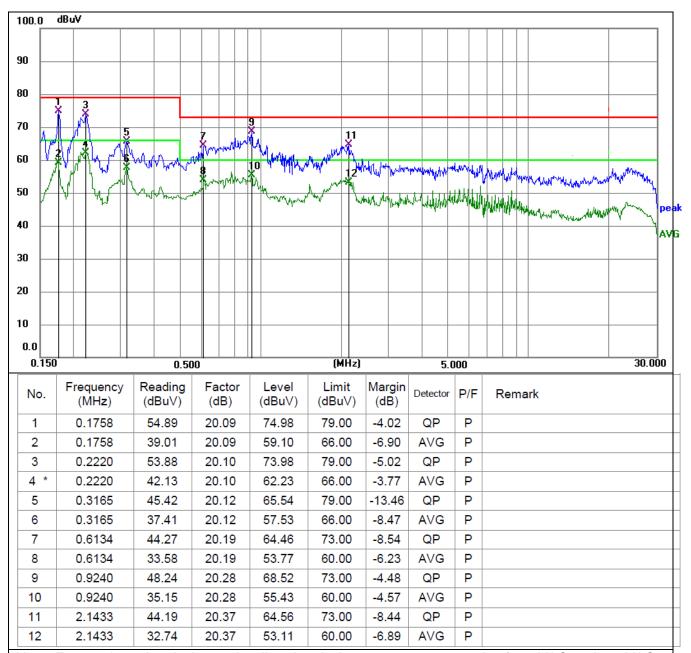
Power on the EUT, the EUT begins to work. Make sure the EUT operates normally during the test.

Maximizing procedure was performed on the six (6) highest emissions of the EUT.

All data was recorded in the Quasi-peak and average detection mode.

#### 3.5. Test Data





Note: For conducted emission and radiated emission test, a power supply of 230VAC and 120VAC was used for testing respectively, and only recorded the worst case of 230VAC.

### 4. RADIATED DISTURBANCE

#### 4.1. Radiated Emission Limit

Relevant Standard(s): EN IEC 61000-6-2:2019 /CISPR 11:2009

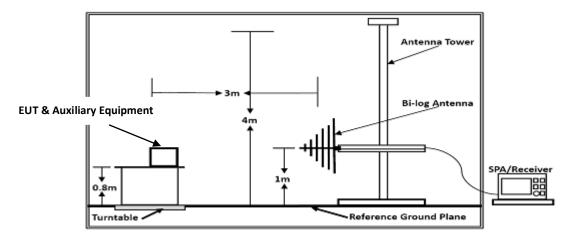
Limits for Radiated Disturbance Below 1GHz				
Frequency Distance Field Strengths Limit				
(MHz)	(Meters)	(dBµV/m)		
30 ~ 230	3	50		
230 ~ 1000	3	57		

<sup>\*\*\*</sup>Note:

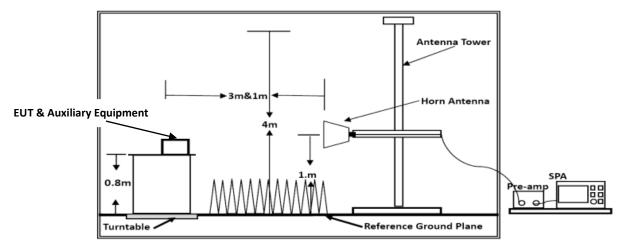
- (1) The smaller limit shall apply at the combination point between two frequency bands.
- (2) Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the EUT.

Limits for Radiated Disturbance Above 1GHz							
Frequency Distance Peak Limit Average Limit (MHz) (Meters) (dBµV/m) (dBµV/m)							
1000 ~ 3000	3	76	56				
3000 ~ 6000 3 80 60							
***Note: The lower limi	***Note: The lower limit applies at the transition frequency.						

## 4.2. Test Configuration



Below 1GHz



Above 1GHz

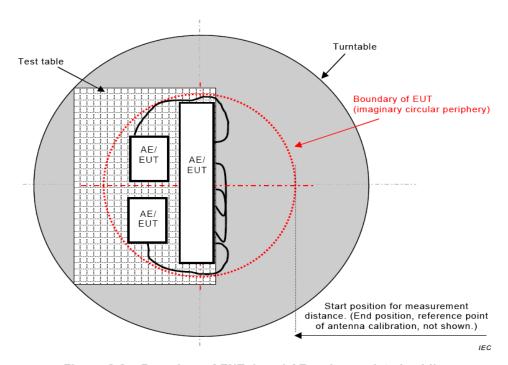


Figure C.2 – Boundary of EUT, Local AE and associated cabling

#### 4.3. Test Procedure

## 1) Sequence of testing 30 MHz to 1 GHz Setup:

- --- The equipment was set up to simulate a typical usage like described in the user manual or described by manufacturer.
- --- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- --- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- --- Auxiliary equipment and cables were positioned to simulate normal operation conditions
- --- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- --- The measurement distance is 3 meter.
- --- The EUT was set into operation.

#### **Pre-measurement:**

- --- The turntable rotates from 0° to 315° using 45° steps.
- --- The antenna is polarized vertical and horizontal.
- --- The antenna height changes from 1 to 4 meter.
- --- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

#### Final measurement:

- --- The final measurement will be performed with minimum the six highest peaks.
- --- According to the maximum antenna and turntable positions of premeasurement the software maximize the peaks by changing turntable position (± 45°) and antenna movement between 1 and 4 meter.
- --- The final measurement will be done with QP detector with an EMI receiver.
- --- The final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit will be recorded. Also a plot with the graph of the pre-measurement with marked maximum final measurements and the limit will be stored.

## 2) Sequence of testing 1 GHz to 6 GHz Setup:

- --- The equipment was set up to simulate a typical usage like described in the user manual or described by manufacturer.
- --- If the EUT is a tabletop system, a rotatable table with 0.8 m height is used.
- --- If the EUT is a floor standing device, it is placed on the ground plane with insulation between
- --- Auxiliary equipment and cables were positioned to simulate normal operation conditions
- --- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- --- The measurement distance is 3 meter.
- --- The EUT was set into operation.

#### Pre-measurement:

- --- The turntable rotates from 0° to 315° using 45° steps.
- --- The antenna is polarized vertical and horizontal.
- --- The antenna height scan range is 1 meter to 4 meter.
- --- At each turntable position and antenna polarization the analyzer sweeps with peak detection to find the maximum of all emissions.

#### **Final measurement:**

- --- The final measurement will be performed with minimum the six highest peaks.
- --- According to the maximum antenna and turntable positions of pre-measurement the software maximize the peaks by changing turntable position (± 45°) and antenna movement between 1 and 4 meter. This procedure is repeated for both antenna polarizations.

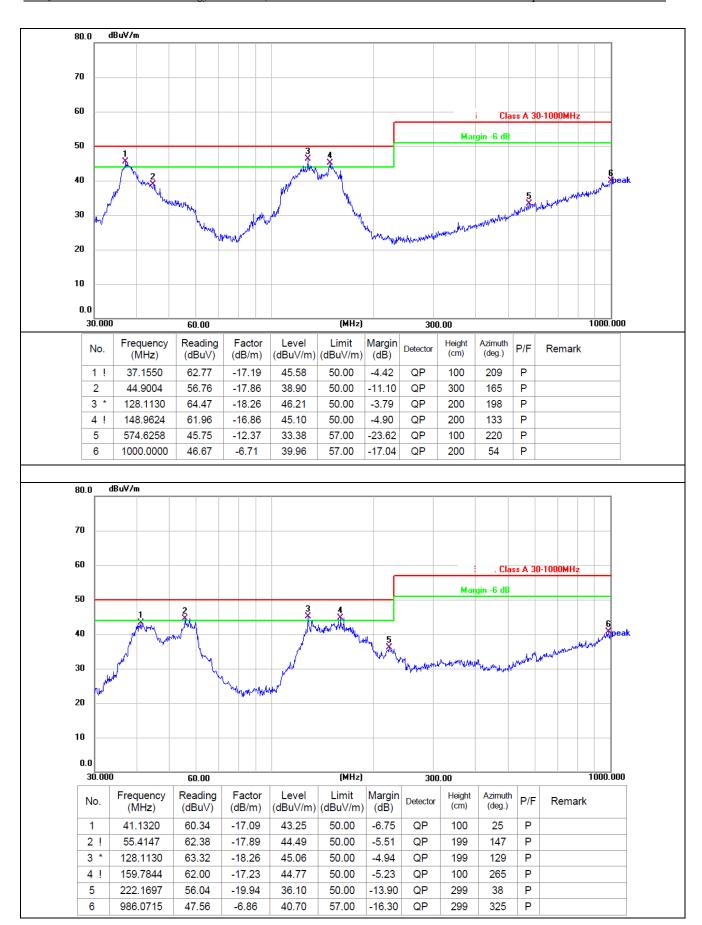
- --- The final measurement will be done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and Average detector.
- --- The final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit will be recorded. Also a plot with the graph of the pre-measurement with marked maximum final measurements and the limit will be stored.

Receiver Parameter	Setting	
Attenuation	Auto	
Start ~ Stop Frequency	30MHz~1000MHz / RBW 100kHz for QP	

Spectrum Parameter	Setting	
Attenuation	Auto	
Start Frequency	1000 MHz	
Stop Frequency	6000 MHz	
DD\\\ / \/D\\\	1MHz / 1MHz for Peak, 1 MHz / 10Hz for	
RBW / VBW	Average	

#### 4.4. Test Data

The worst test mode of the EUT was TM1, and its test data was showed as the follow:



Test Mode: TM1 (Above 1GHz)				Test Dista	ance: 3m		
Test Voltage: AC 380V/50Hz			Test Results: Passed				
Detector Fu	ınction: Pea	k + AV					
Polarizatio n	Frequenc y (MHz)	Emission Level (dBµV/m)		Limit (dBµV/m)		Margin (dB)	
	1350.63	50.09	37.90	76.00	56.00	-19.91	-12.10
	1884.93	47.85	36.33	76.00	56.00	-22.15	-13.67
Horizontal	2188.83	49.02	31.69	76.00	56.00	-24.98	-22.31
Honzoniai	3290.43	56.29	31.63	80.00	60.00	-17.71	-22.37
	4332.04	51.33	34.55	80.00	60.00	-22.67	-19.45
	5886.54	53.77	36.46	80.00	60.00	-20.23	-17.54
	1350.31	50.01	36.54	76.00	56.00	-19.99	-13.46
	1884.74	47.84	36.12	76.00	56.00	-22.16	-13.88
Vertical	2191.17	48.03	30.57	76.00	56.00	-25.97	-23.43
Vertical	3294.60	57.43	33.09	80.00	60.00	-16.57	-20.91
	4328.72	50.94	35.04	80.00	60.00	-23.06	-18.96
	5884.18	55.10	36.79	80.00	60.00	-18.90	-17.21

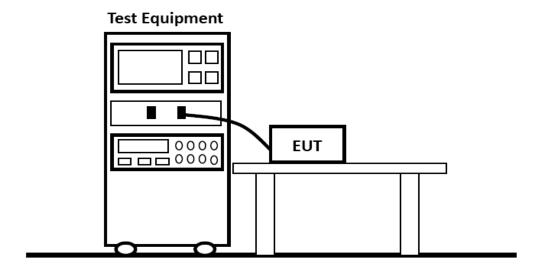
<sup>1.</sup> Field strength limits for frequency above 1000MHz are based on average limits. However, Peak mode field strength shall not exceed the average limits specified plus 20dB.

<sup>2.</sup> Measurements above show only up to 6 maximum emissions noted.

<sup>3.</sup> Data of measurement within this frequency range shown " -- " in the table above means the reading of emissions are attenuated more than 20dB below the permissible limits or the field strength is too small to be measured.

## 5. HARMONIC CURRENT EMISSIONS

## 5.1. Test Configuration



### 5.2. Test Standard

According to EN IEC 61000-6-2:2019 & EN 61000-3-2: 2014

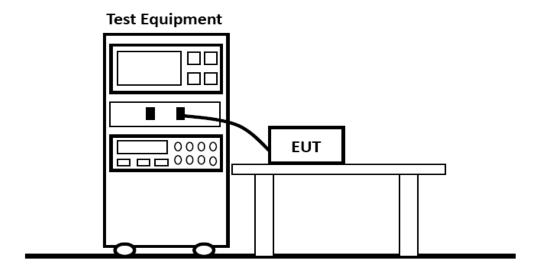
### 5.3. Test Data

Test Model	WM1660SPE	Test Engineer	Jason Li
Environmental Conditions	24.6°C, 52.6% RH	Test Voltage	AC 380V/50Hz

Because power of EUT less than 75W, According standard EN 61000-3-2, Harmonic current unnecessary to test.

## 6. VOLTAGE FLUCTUATION AND FLICKER

## 6.1. Test Configuration



### 6.2. Test Standard

According to EN IEC 61000-6-2:2019 & EN 61000-3-3: 2013

### 6.3. Test Data

PASS.

### 7. GENERAL PERFORMANCE CRITERIA FOR IMMUNITY TEST

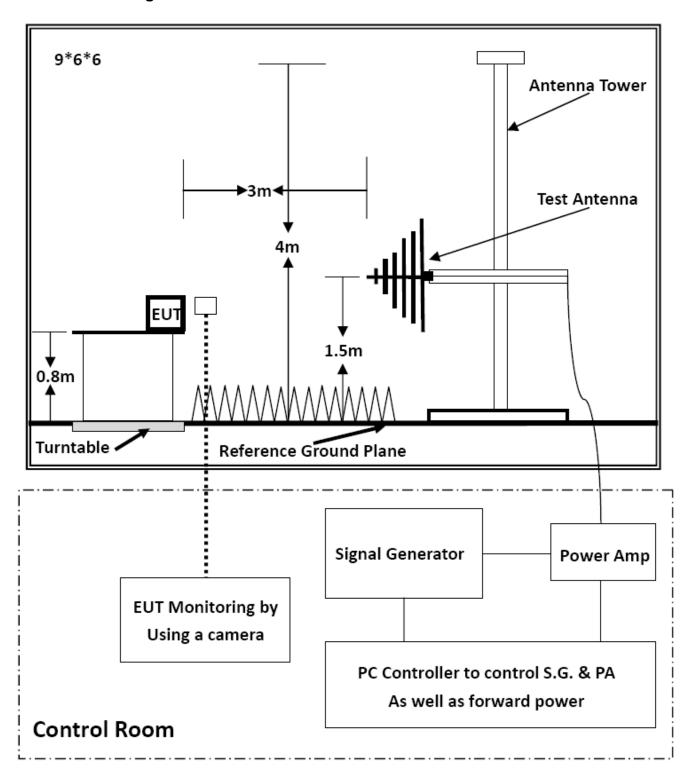
#### Performance criteria for EN IEC 61000-6-2

A functional description and a definition of specific performance criteria, during or as a consequence of immunity testing of equipment under test (EUT), shall be provided by the manufacturer and noted in the test report. They shall be consistent with one of the following general criteria for each test as specified in Table 1 to Table 4:

- a) Performance criterion A: The EUT shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the EUT is used as intended. If the performance level is not specified by the manufacturer, this may be derived from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.
- b) Performance criterion B: The EUT shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. However, during the test degradation of performance is allowed but no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.
- c) Performance criterion C: Temporary loss of function is allowed during the test, provided the function is self-recoverable or can be restored by the operation of the controls.
- If, as a result of the application of the tests defined in this standard, the EUT becomes dangerous or unsafe, it shall be deemed to have failed the test.

## 8. RF ELECTROMAGNETIC FIELD (80 MHz - 1000 MHz)

## 8.1. Test Configuration



#### 8.2. Test Standard

EN 61000-6-2, EN61000-4-3

Test level 3 at 10V/m.

### 8.3. Severity Level

Level	Field Strength (V/m)	
1	1	
2	3	
3	10	
X	Special	
Performance Criterion	: A	

## 8.4. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually. In order to judge the EUT performance, a CCD camera is used to monitor EUT screen. All the scanning conditions are as follows:

Condition of Test	Remark	
Fielded Strength	10 V/m (Severity Level 2)	
Radiated Signal	Unmodulated	
Scanning Frequency	80-1000MHz	
Dwell time of radiated	0.0015 decade/s	
Waiting Time	3 Sec.	

## 8.5. Test Result

Test Model	WM1660SPE	Test Engineer	Jason Li
Environmental Conditions	23.5℃, 53.2% RH	Test Voltage	AC 380V/50Hz

### 2.4G TM1 Test Result:

EUT Working Mode	Antenna Polarity	Frequency (MHz)	Fielded Strength (V/m)	Observation	Position	Conclusio n
Operating Mode	Vertical	80-1000	10	CT, CR	Front, Right, Left, Back	Pass
Operating Mode H	Horizont al	80-1000	10	CT, CR	Front, Right, Left, Back	Pass
Idle	Vertical	80-1000	10	See Note	Front, Right, Left, Back	Pass
iule	Horizont al	80-1000	10	See Note	Front, Right, Left, Back	Pass

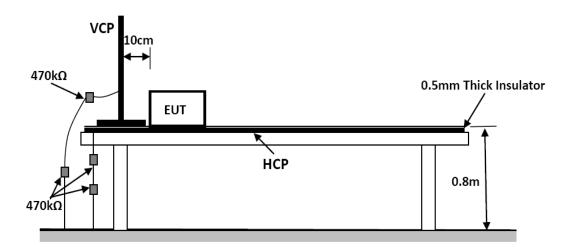
### TM2-TM3 Test Result:

EUT Working Mode	Antenna Polarity	Frequency (MHz)	Fielded Strength (V/m)	Observation	Position	Conclusio n
Operating Mode	Vertical	80-1000	10	See Note	Front, Right, Left, Back	Pass
Operating Mode Horizo	Horizont al	80-1000	10	See Note	Front, Right, Left, Back	Pass
Idle	Vertical	80-1000	10	See Note	Front, Right, Left, Back	Pass
iule	Horizont al	80-1000	10	See Note	Front, Right, Left, Back	Pass

#### 9. ELECTROSTATIC DISCHARGE

Please refer to ETSI EN 301 489-1 and EN 61000-4-2.

#### 9.1. Test Configuration



EN 61000-4-2 specifies that a tabletop EUT shall be placed on a non-conducting table which is 80 centimeters above a ground reference plane and that floor mounted equipment shall be placed on a insulating support approximately 10 centimeters above a ground plane. During the tests, the EUT is positioned over a ground reference plane in conformance with this requirement.

For tabletop equipment, a 1.5 by 1.0-meter metal sheet (HCP) is placed on the table and connected to the ground plane via a metal strap with two 470 k Ohms resistors in series. The EUT and attached cables are isolated from this metal sheet by 0.5-millimeter thick insulating material. A Vertical Coupling Plane (VCP) grounded on the ground plane through the same configuration as in the HCP is used.

#### 9.2. Test Procedure

EN IEC 61000-6-2:2019 / EN 61000-4-2: 2009

Test level 3 for Air Discharge at ±8 kV

Test level 2 for Contact Discharge at ±4 kV

#### 9.2.1. Air Discharge

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### 9.2.2. Contact Discharge

All the procedure shall be same as Section 9.2.1. except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

#### 9.2.3. Indirect Discharge For Horizontal Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

#### 9.2.4. Indirect Discharge For Vertical Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

#### 9.3. Test Data

PASS.

Electrostatic Discharge Test Results						
Standard	☐ IEC 61000-4-2 ☑ EN 61000-4-2					
Applicant	Applicant Shanghai Maitu Chemical Technology Ltd					
EUT	Ink-jet printer	Temperature	23.5℃			
M/N	WM1660SPE	Humidity	53.1%			
Criterion	В	Pressure	1021mbar			
Test Mode	TM1-TM3	Test Date				
Test Engineer	Jason Li					

### **TEST RESULT OF TM1**

Test Voltage	Coupling	Observation	Result (Pass/Fail)
±2KV, ±4kV	Contact Discharge	CT, CR	Pass
±2KV, ±4kV, ±8kV	Air Discharge	CT, CR	Pass
±2KV, ±4kV	Indirect Discharge HCP	CT, CR	Pass
±2KV, ±4kV	Indirect Discharge VCP	CT, CR	Pass

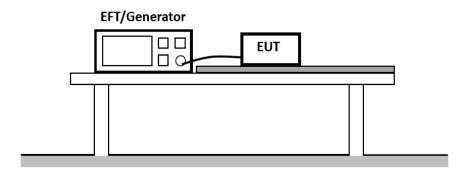
#### **TEST RESULT OF TM2-TM3**

1201 112021 01 11112 11110					
Test Voltage Coupling		Result (Pass/Fail)			
±2KV, ±4kV	Contact Discharge	Pass			
±2KV, ±4kV, ±8kV	Air Discharge	Pass			
±2KV, ±4kV	Indirect Discharge HCP	Pass			
±2KV, ±4kV	Indirect Discharge VCP	Pass			

Note: The EUT performance complied with performance criteria for CT&CR to MS Function and there is no any degradation of performance and function.

### 10. ELECTRICAL FAST TRANSIENT IMMUNITY

#### 10.1. Test Configuration



#### 10.2. Test Standard

EN IEC 61000-6-2:2019/ EN61000-4-4: 2012

Test level 2 kV

1621 16761 Z KV					
Test Level					
Open (	Circuit Output Test Voltage ±1	0%			
Level On Power Supply Lines On I/O (Input/Output) Signal data and control lines					
1	0.5 kV	0.25 kV			
2	1 kV	0.5 kV			
3	2 kV	1 kV			
4	4 kV	2 kV			
X	Special	Special			
Performance Criterion: B					

## 10.3. Test Procedure

The EUT is put on the table, which is 0.8 meter high above the ground. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

#### 10.3.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device, which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.

- 10.3.2. For signal lines and control lines ports: No I/O ports. It's unnecessary to test.
- 10.3.3. For DC output line ports: It's unnecessary to test.

#### 10.4. Test Data

#### PASS.

Please refer to the following page.

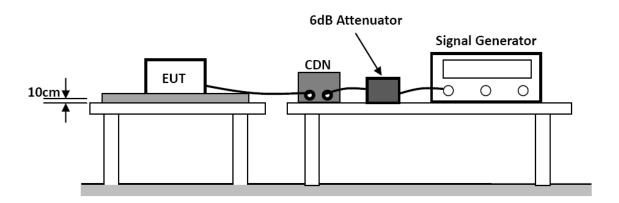
El Results	ectrical Fast Tra	ansient/l	Burst	Test
Standard	☐ IEC 61000-4-4 ☐ EN 61000-4-4	4		
Applicant	Shanghai Maitu Chemical Technology	Ltd		
EUT	Ink-jet printer	Temperature	24.6°C	
M/N	WM1660SPE	Humidity	52.6%	
Test Mode	TM1-TM3	Criterion	В	
Test Engineer	Jason Li			

TEST RESULT OF TM1					
Line	Test Voltage	Result (Pass/Fail)			
L	2KV	+/-	CT, CR	Pass	
N	2KV	+/-	CT, CR	Pass	
L-N	2KV	+/-	CT, CR	Pass	

TEST RESULT OF TM2-TM3					
Line	Test Voltage	Polarity	Result (Pass/Fail)		
L	2KV	+/-	Pass		
N	2KV	+/-	Pass		
L-N	2KV	+/-	Pass		

## 11. RF COMMON MODE

## 11.1. Test Configuration



### 11.2. Test Standard

EN IEC 61000-6-2:2019/ EN 61000-4-6: 2014 Test level 3 at 310V (r.m.s.),  $0.15 \text{ MHz} \sim 80 \text{ MHz}$ ,

Modulation type: AM Modulation depth: 80% Modulation signal: 1 kHz

Modulation signal. 1 Ki iz	-					
Te	Test Level					
Level Voltage Level (r.m.s) (V)						
1	1					
2	3					
3	10					
X	Special					
Performance Criterion: A						

#### 11.3. Test Procedure

- 11.3.1. Let the EUT work in test mode and test it.
- 11.3.2. The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50mm (where possible).
- 11.3.3. The disturbance signal described below is injected to EUT through CDN.
- 11.3.4. The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 11.3.5. The frequency range is swept from 150kHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave.
- 11.3.6. The rate of sweep shall not exceed 1.5\*10-3 decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 11.3.7. Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

#### 11.4. Test Data

#### PASS.

Please refer to the following page.

Injected Currents Susceptibility Test Results					
Standard	□ IEC 61000-4-6 ☑ EN 61000-4	☐ IEC 61000-4-6 ☑ EN 61000-4-6			
Applicant	Shanghai Maitu Chemical Technology Ltd				
EUT	Ink-jet printer Temperature 22.6°C				
M/N	WM1660SPE	52.3%			
Test Mode	TM1-TM3 Criterion A				
Test Engineer	Jason Li				

TEST RESULT OF TM1				
Frequency Injected Strength Observation Result (Pass				
0.15 ~ 80	AC Mains	3V	CT, CR	Pass

TEST RESULT OF TM2-TM3					
Frequency Injected Strength Range (MHz) Position (Unmodulated) Result (Pass/Fail)					
0.15 ~ 80	AC Mains	10V	Pass		

### Remark:

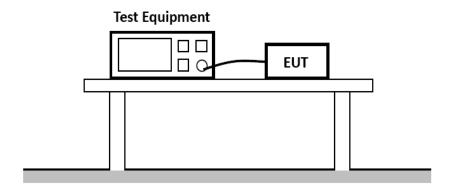
1. Modulation Signal:1kHz 80% AM 2. Measurement Equipment :

Simulator: CIT-10 (FRANKONIA)

CDN : ☑CDN-M2 (FRANKONIA) □CDN-M3 (FRANKONIA)

## 12. SURGES, LINE TO LINE AND LINE TO GROUND

### 12.1. Test Configuration



#### 12.2. Test Standard

EN IEC 61000-6-2:2019 / EN 61000-4-5: 2014

L-N: Test level 2 at 1 kV

L-PE. N-PE Test Level 3 at 2kV

LIL, IVI LICST LOVE O AT ZRV						
	Test Level					
Open (	Circuit Output Test Voltage ±1	0%				
Level On Power Supply Lines On I/O (Input/Output) Signal data and control lines						
1	0.5 kV	0.25 kV				
2	1 kV	0.5 kV				
3	2 kV	1 kV				
4	4 kV	2 kV				
X	Special	Special				
Performance Criterion: B						

### 12.3. Test Procedure

- 12.3.1. For line to line coupling mode, provide a 0.5 kV 1.2/50us voltage surge (at open-circuit condition).
- 12.3.2. At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 12.3.3. Different phase angles are done individually.
- 12.3.4. Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

## 12.4. Test Data

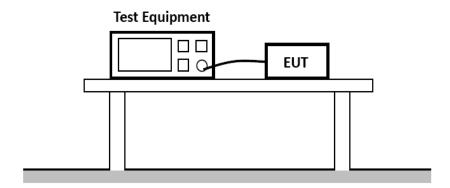
Surge Immunity Test Result					
Standard	□ IEC 61000-4-5 ☑ EN 61000-4-5				
Applicant	Shanghai Maitu Chemical Technology Ltd				
EUT	Ink-jet printer Temperature 24.6°C				
M/N	WM1660SPE Humidity 52.6%				
Test Mode	TM1-TM3 Criterion A				
Test Engineer	Jason Li				

TEST RESULT OF TM1						
Location	Polarity	I Phaco Andio	Number of Pulse	Pulse Voltage (KV)	Observation	Result (Pass/Fail)
L-N	+	0°, 90°, 180°, 270°	5	1.0	CT, CR	Pass
L-IN	-	0°, 90°, 180°, 270°	5	1.0	CT, CR	Pass

TEST RESULT OF TM2-TM3					
Location	Polarity	Phase Angle	Number of Pulse	Pulse Voltage (KV)	Result (Pass/Fail)
L-N	+	0°, 90°, 180°, 270°	5	1.0	Pass
L-IN	-	0°, 90°, 180°, 270°	5	1.0	Pass

## 13. VOLTAGE DIPS/INTERRUPTIONS IMMUNITY TEST

## 13.1. Test Configuration



### 13.2. Test Standard

EN IEC 61000-6-2:2019/ EN 61000-4-11: 2004

Test levels and Performance Criterion

Test Level				
Voltage Reduction	Voltage Dips	Duration		
¯ %U <sub>T</sub>	%U <sub>T</sub>	(in Period)		
100	0	0.5		
100	0	1		
30	70	5		
Voltage Reduction	Voltage Dips	Duration		
¯ %U <sub>T</sub>	%Ū <sub>T</sub>	(in Period)		
100	0	250		
Performance Criterion: B&C				

### 13.3. Test Procedure

- 13.3.1. The interruption is introduced at selected phase angles with specified duration.
- 13.3.2. Record any degradation of performance.

## 13.4. Test Data

Voltage Dips And Interruptions Test Results			
Standard	□ IEC 61000-4-11 ☑ EN 61000-4-1	1	
Applicant	Shanghai Maitu Chemical Technology Ltd		
EUT	Ink-jet printer	Temperature	24.6°C
M/N	WM1660SPE	Humidity	52.6%
Test Mode	TM1-TM3	Criterion	А
Test Engineer	Jason Li		

TEST RESULT OF TM1				
Test Level % U <sub>T</sub>	Voltage Dips & Short Interruptions % U <sub>T</sub>	Duration (in periods)	Observation	Result (Pass/Fail)
0	100	0.5P	CT, CR	Pass
0	100	1P	CT, CR	Pass
40	100	0.5P	CT, CR	Pass
40	100	1P	CT, CR	Pass
70	30	25P	CT, CR	Pass
0	100	250P	CT, CR	Pass

TEST RESULT OF TM2-TM3				
Test Level % U <sub>T</sub>	Voltage Dips & Short Interruptions % U <sub>T</sub>	Duration (in periods)	Result (Pass/Fail)	
0	100	0.5P	Pass	
0	100	1P	Pass	
40	100	0.5P	Pass	
40	100	1P	Pass	
70	30	25P	Pass	
0	100	250P	Pass	

## 14. Setup Photographs



Fig.1





Fig.3



Fig.4

## -----THE END OF REPORT-----